


<b>Search Notes</b> 	<b>Application/Control No.</b> 10518223	<b>Applicant(s)/Patent Under Reexamination</b> CHENG ET AL.
	<b>Examiner</b> IQBAL H CHOWDHURY	<b>Art Unit</b> 1652

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SEARCH NOTES		
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STN and WEST Databases- updated search of 3/10/2010	7/12/2010	IC

INTERFERENCE SEARCH			
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